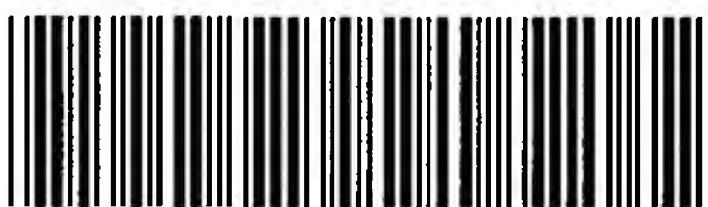


Search Notes



Application/Control No.

10/710,673

Examiner

Hiep Nguyen

**Applicant(s)/Patent under
Reexamination**

LEE ET AL.

Art Unit

2816

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB search	6/29/2006	HN	